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Supplementary Information

Lightwave trapping in thin film solar cells with improved photonic-structured front contacts

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Section S1 – EDX analysis

Figure S1 presents the measured energy-dispersive X-ray spectroscopy (EDX) results of TiO_2 and IZO films deposited by sputtering, in order to analyze the composition of the photonic coating materials applied on the solar cells' front. As expected, peaks corresponding to the different elements presented in the structures appear: Ti and O, in the case of the TiO_2 analysis, and In, Zn and O for the IZO film. Both EDX spectra also reveal a pronounced peak corresponding to Si, since to carry out this analysis TiO_2 and IZO were sputtered directly on glass substrates.

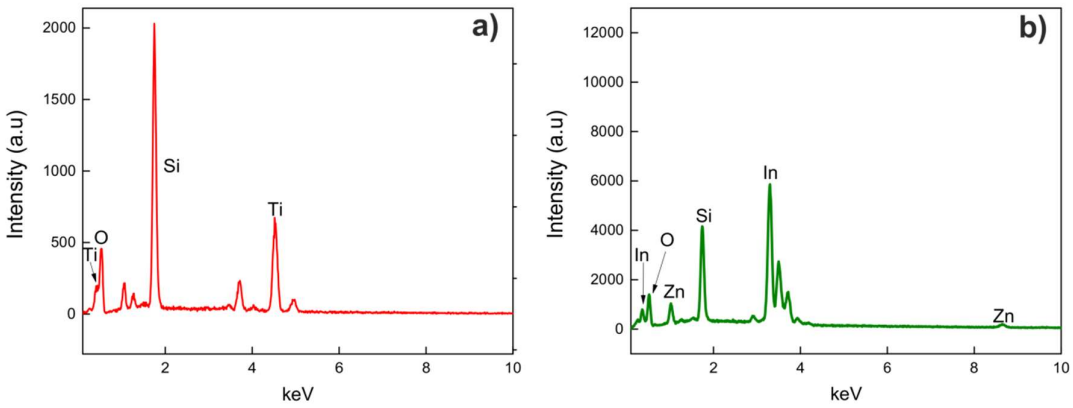

***Figure S1**. EDX analysis corresponding to TiO_2 a) and IZO b) films deposited on glass substrates.*